

SKM1000GB17E4



IGBT4 Modules

SKM1000GB17E4

Features*

- Symmetrical current sharing
- Low-inductive module design
- High mechanical robustness
- UL recognized, file no. E63532

Typical Applications

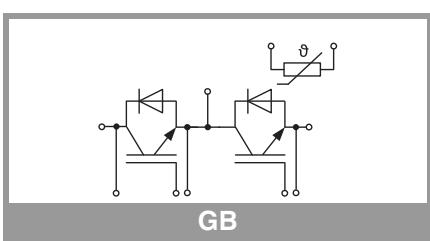
- Motor Drives
- UPS Systems
- Solar Inverters

Remarks

Recommended T_{jop} = -40 ... +150°C
 $I_{DC} \leq 1000A$ for $T_{Terminal} = 100^\circ C$

Absolute Maximum Ratings		Values	Unit
Symbol	Conditions		
IGBT			
V_{CES}	$T_j = 25^\circ C$	1700	V
I_C	$T_j = 175^\circ C$	1300	A
	$T_c = 25^\circ C$	850	A
I_{Cnom}	$T_c = 100^\circ C$	1000	A
I_{CRM}		2000	A
V_{GES}		-20 ... 20	V
t_{psc}	$V_{CC} = 1000 V$ $V_{GE} \leq 15 V$ $V_{CES} \leq 1700 V$	10	μs
T_j		-40 ... 175	$^\circ C$
Inverse diode			
V_{RRM}	$T_j = 25^\circ C$	1700	V
I_F	$T_j = 175^\circ C$	1427	A
	$T_c = 25^\circ C$	890	A
I_{IFRM}	$T_c = 100^\circ C$	2000	A
I_{FSM}	$t_p = 10 ms, \sin 180^\circ, T_j = 25^\circ C$	6240	A
T_j		-40 ... 175	$^\circ C$
Module			
$I_{t(RMS)}$		1000	A
T_{stg}		-40 ... 150	$^\circ C$
V_{isol}	AC sinus 50 Hz, $t = 1$ min	4000	V

Characteristics		min.	typ.	max.	Unit
Symbol	Conditions				
IGBT					
$V_{CE(sat)}$	$I_C = 1000 A$ $V_{GE} = 15 V$ chiplevel	$T_j = 25^\circ C$	1.99	2.31	V
		$T_j = 150^\circ C$	2.44	2.77	V
V_{CE0}	chiplevel	$T_j = 25^\circ C$	1.10	1.20	V
		$T_j = 150^\circ C$	1.00	1.10	V
r_{CE}	$V_{GE} = 15 V$ chiplevel	$T_j = 25^\circ C$	0.89	1.11	$m\Omega$
		$T_j = 150^\circ C$	1.44	1.67	$m\Omega$
$V_{GE(th)}$	$V_{GE}=V_{CE}, I_C = 36 mA$		5.2	5.8	6.4
I_{CES}	$V_{GE} = 0 V, V_{CE} = 1700 V, T_j = 25^\circ C$			5	mA
C_{ies}				70.8	nF
C_{oes}	$V_{CE} = 25 V$ $V_{GE} = 0 V$	$f = 1 MHz$		2.58	nF
C_{res}		$f = 1 MHz$		2.28	nF
Q_G	$V_{GE} = +15V / -15 V$			7200	nC
R_{Gint}	$T_j = 25^\circ C$			1.5	Ω
$t_{d(on)}$	$V_{CC} = 900 V$	$T_j = 150^\circ C$		730	ns
t_r	$I_C = 1000 A$	$T_j = 150^\circ C$		115	ns
E_{on}	$V_{GE} = +15/-15 V$	$T_j = 150^\circ C$		450	mJ
$t_{d(off)}$	$R_{G\ on} = 1.2 \Omega$ $R_{G\ off} = 1.2 \Omega$	$T_j = 150^\circ C$		990	ns
t_f	$di/dt_{on} = 8.2 kA/\mu s$ $di/dt_{off} = 4.7 kA/\mu s$	$T_j = 150^\circ C$		175	ns
E_{off}	$dv/dt = 3800 V/\mu s$ $L_s = 25 nH$	$T_j = 150^\circ C$		370	mJ
$R_{th(j-c)}$	per IGBT			0.034	K/W
$R_{th(c-s)}$	per IGBT ($\lambda_{grease}=0.81 W/(m^*K)$)			0.016	K/W
$R_{th(c-s)}$	per IGBT, pre-applied phase change material			0.013	K/W



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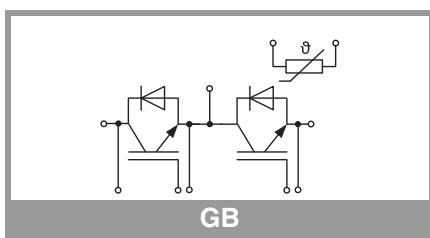
Typical Applications

- Motor Drives
- UPS Systems
- Solar Inverters

Remarks

Recommended $T_{jop} = -40 \dots +150^\circ\text{C}$
 $I_{DC} \leq 1000\text{A}$ for $T_{\text{Terminal}} = 100^\circ\text{C}$

Characteristics		Symbol	Conditions	min.	typ.	max.	Unit
Inverse diode							
$V_F = V_{EC}$	$I_F = 1000\text{ A}$		$T_j = 25^\circ\text{C}$		1.78	2.12	V
	$V_{GE} = 0\text{ V}$ chiplevel		$T_j = 150^\circ\text{C}$		1.81	2.14	V
V_{FO}	chiplevel		$T_j = 25^\circ\text{C}$		1.32	1.56	V
			$T_j = 150^\circ\text{C}$		1.08	1.22	V
r_F	chiplevel		$T_j = 25^\circ\text{C}$		0.46	0.56	$\text{m}\Omega$
			$T_j = 150^\circ\text{C}$		0.73	0.92	$\text{m}\Omega$
I_{RRM}	$I_F = 1000\text{ A}$		$T_j = 150^\circ\text{C}$		800		A
Q_{rr}	$dI/dt_{\text{off}} = 8.38\text{ kA}/\mu\text{s}$		$T_j = 150^\circ\text{C}$		360		μC
E_{rr}	$V_{GE} = -15\text{ V}$ $V_{CC} = 900\text{ V}$		$T_j = 150^\circ\text{C}$		200		mJ
$R_{\text{th(j-c)}}$	per diode				0.043		K/W
$R_{\text{th(c-s)}}$	per diode ($\lambda_{\text{grease}}=0.81\text{ W}/(\text{m}^*\text{K})$)				0.017		K/W
$R_{\text{th(c-s)}}$	per diode, pre-applied phase change material				0.014		K/W
Module							
L_{CE}					10		nH
$R_{CC'+EE'}$	measured per switch, $T_C = 25^\circ\text{C}$				0.2		$\text{m}\Omega$
$R_{\text{th(c-s)1}}$	calculated without thermal coupling ($\lambda_{\text{grease}}=0.81\text{ W}/(\text{m}^*\text{K})$)				0.0041		K/W
$R_{\text{th(c-s)2}}$	including thermal coupling, T_s underneath module ($\lambda_{\text{grease}}=0.81\text{ W}/(\text{m}^*\text{K})$)				0.007		K/W
$R_{\text{th(c-s)2}}$	including thermal coupling, T_s underneath module, pre-applied phase change material				-		K/W
M_s	to heat sink M5			4	6		Nm
M_t		to terminals M8		8	10		Nm
		to terminals M4		1.8	2.1		Nm
w					1250		g
Temperature Sensor							
R_{100}	$T_c=100^\circ\text{C}$ ($R_{25}=5\text{ k}\Omega$)				493 \pm 5%		Ω
$B_{100/125}$	$R_{(T)}=R_{100}\exp[B_{100/125}(1/T-1/T_{100})]$; $T[\text{K}]$;				3550 $\pm 2\%$		K



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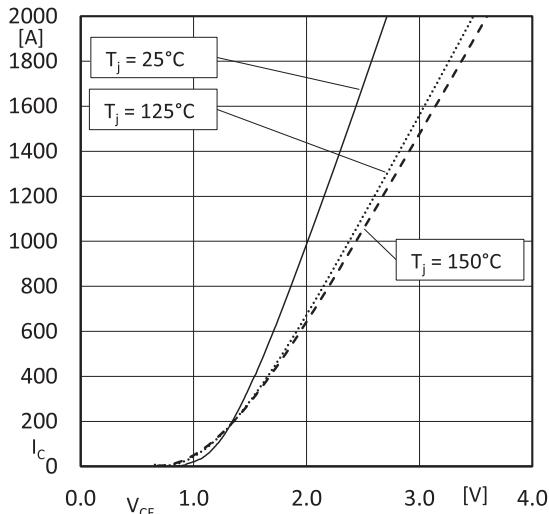


Fig. 1: Output characteristics IGBT (typical); $I_C = f(V_{CE})$; $V_{GE} = 15V$; (chiplevel)

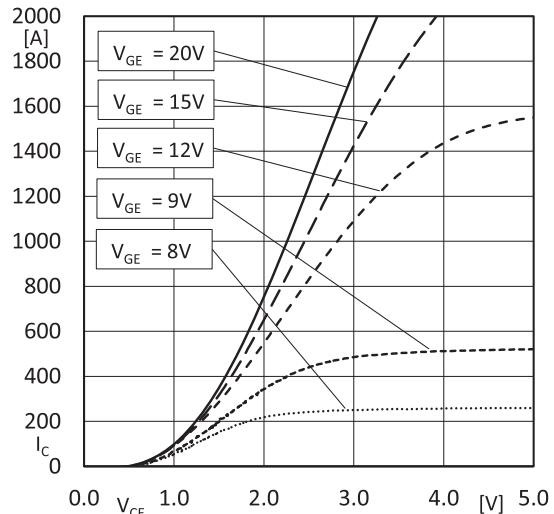


Fig. 2: Output characteristics IGBT (typical); $I_C = f(V_{CE})$; $T_j = 150^\circ C$; (chiplevel)

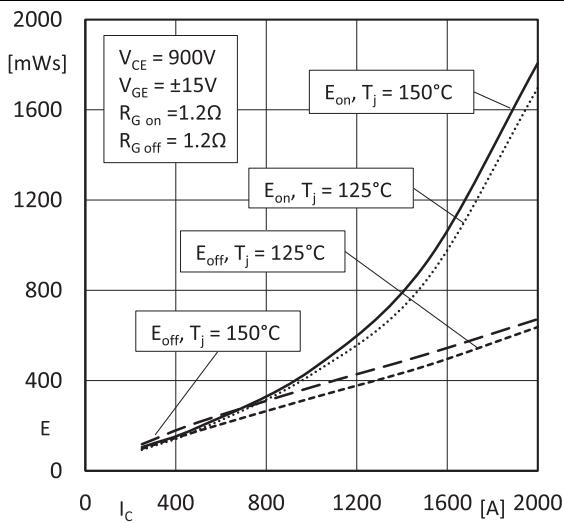


Fig. 3: Switching losses IGBT (typical); $E = f(I_C)$

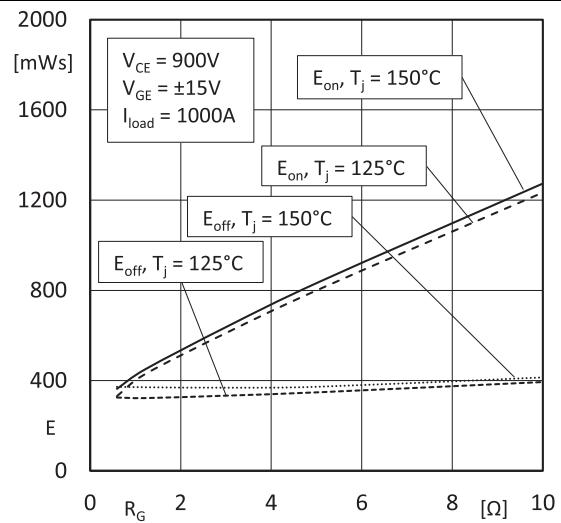


Fig. 4: Switching losses IGBT (typical); $E = f(R_G)$

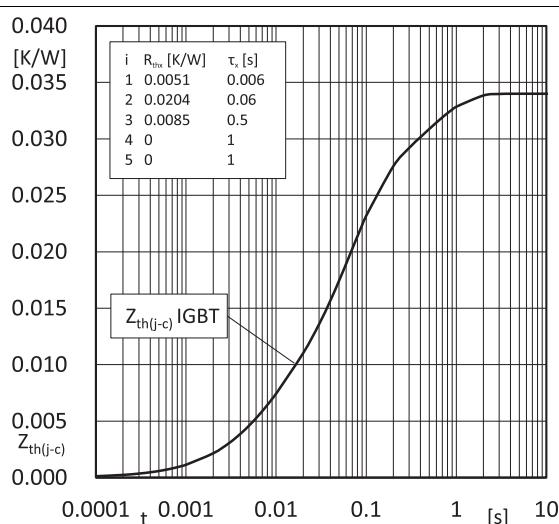


Fig. 5: Transient thermal impedance IGBT

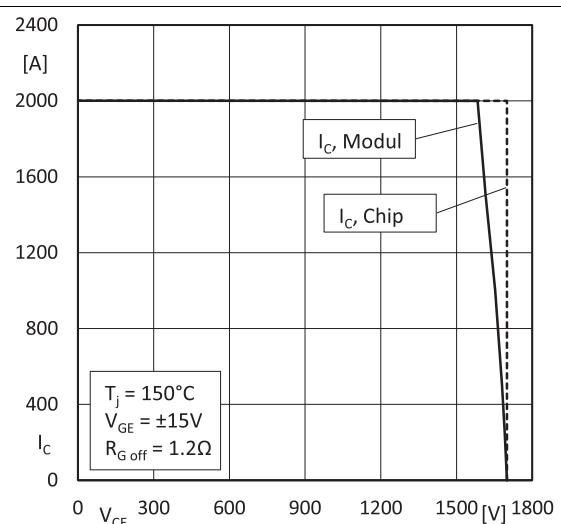


Fig. 6: RBSOA IGBT

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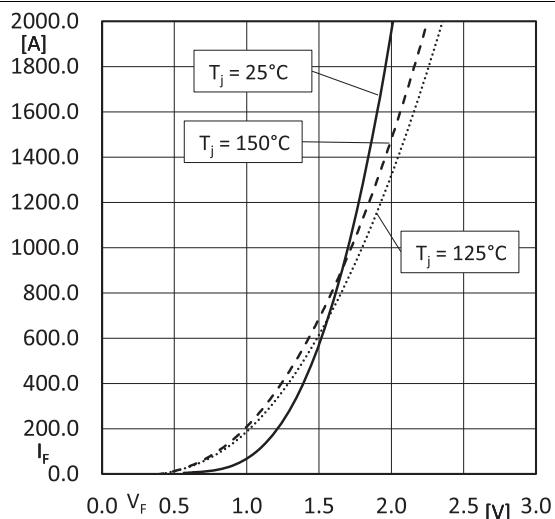


Fig. 7: Forward charact. Diode (typical); $I_F=f(V_F)$; (chiplevel)

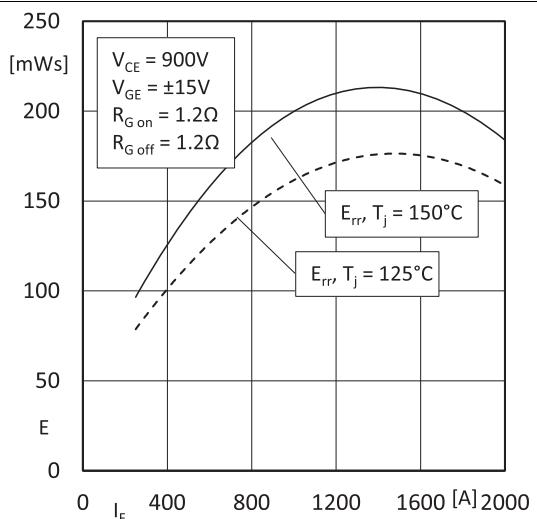


Fig. 8: Switching losses Diode (typical); $E=f(I_F)$

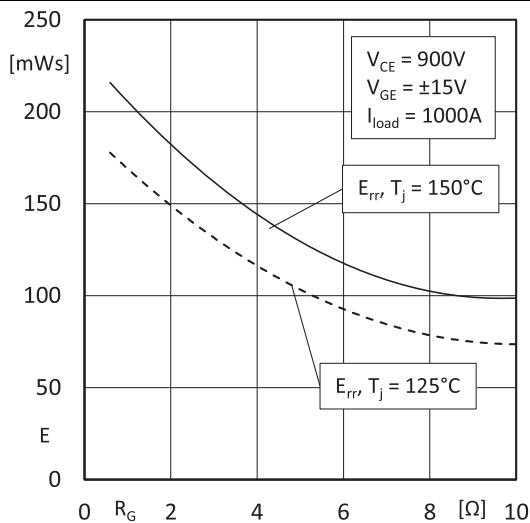


Fig. 9: Switching losses Diode (typical); $E=f(R_G)$

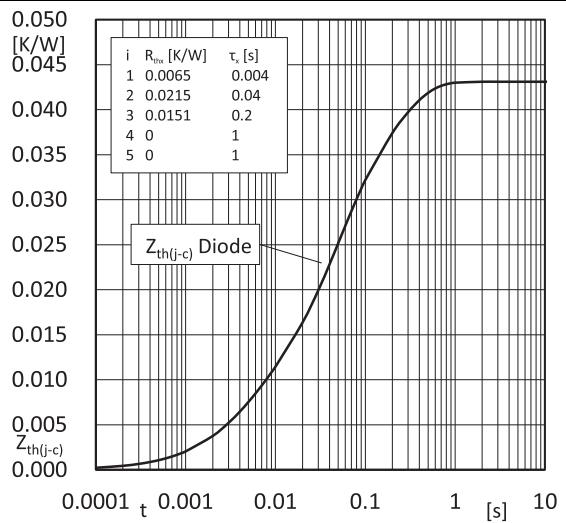


Fig. 10: Transient thermal impedance Diode

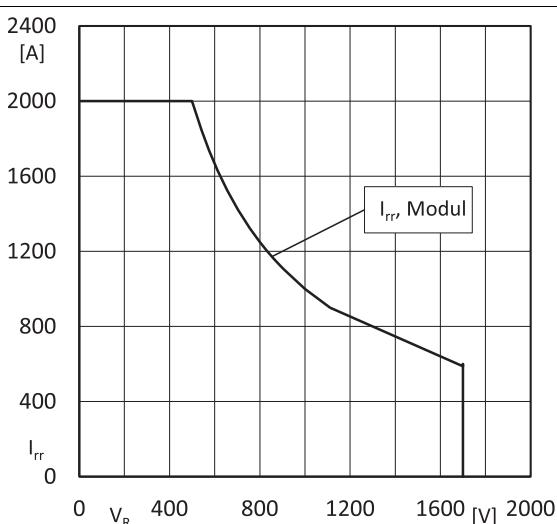


Fig. 11: RBSOA Diode

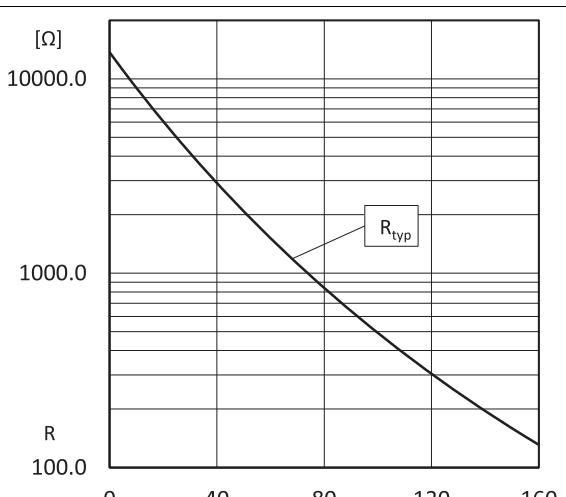


Fig. 12: NTC characteristics (typical)

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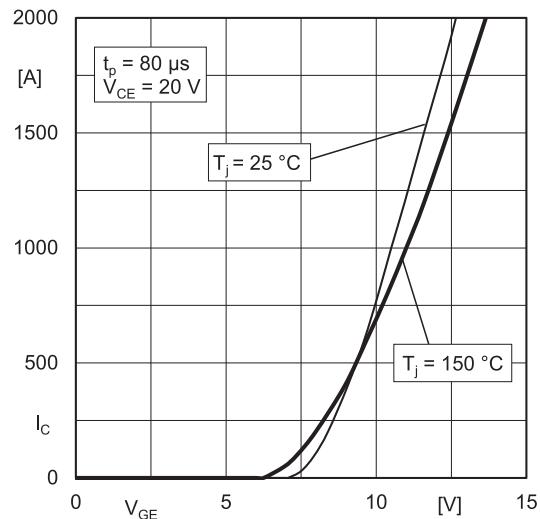


Fig. 13: Typ. transfer characteristic

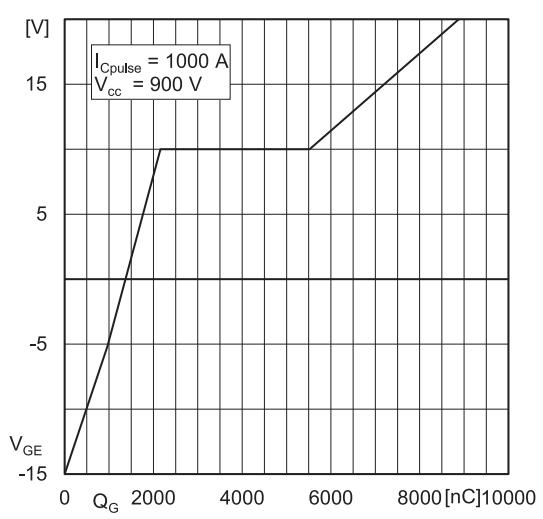
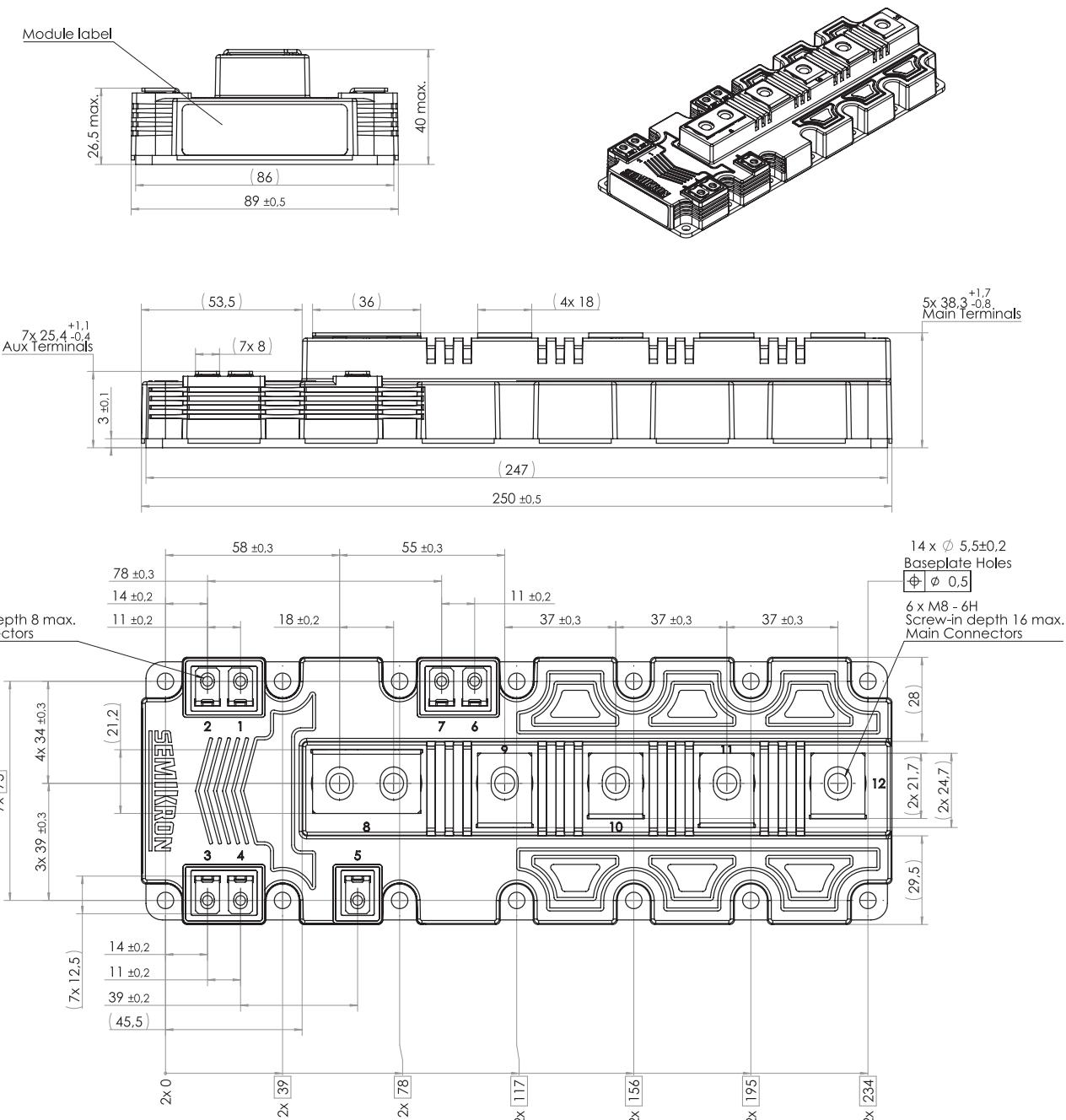
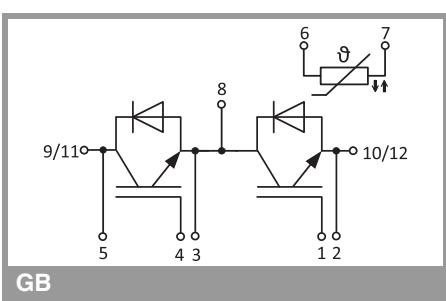


Fig. 14: Typ. gate charge characteristic

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SEMITRANS 10



This is an electrostatic discharge sensitive device (ESDS) due to international standard IEC 61340.

*IMPORTANT INFORMATION AND WARNINGS

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